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EXAMINER INITIAL				DOC	UMENT NU		ATENT	DOCUM	DATE	NAME	CLASS	SUBCLASS
B.K.		3	3	1	8	9	.0	0	5/9/67	Janssen	260	294
B.K.		3	9	6	3	7	2	7	6/15/76	Ueno et al.	260	293
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13.K.	EP	0	9	9	0	8	5	3	4/5/00	EPO		
1.K.	wo	9	7		0	8	3		10/30/97	PCT		

		OTHER DOCUMENTS (Includ	ling Author, Title, Date, Pertinent Pages	, Etc.)							
S.K.	4	Patent Abstract of Japan, Vol. 013, No. 249 (C-605), (9 June 1989) (JP 01 056617 A, 3 March 1989).									
D.K.	,	Patent Abstract of Japan, Vol. 1999, No.	o. 03, (31 March 1999) (JP 10 330377 A, 15	1999) (JP 10 330377 A, 15 December 1998).							
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EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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